

-60V P-Channel Power MOSFET

• **General Description**

It combines trench MOSFET technology with a low resistance package to provide extremely low $R_{DS(ON)}$.

• **Features**

- AEC-Q101 Qualified
- Low $R_{DS(ON)}$ to minimize conductive loss
- High GOX reliability
- Low Thermal resistance

• **Application**

- BLDC Motor driver
- DC-DC
- Load Switch

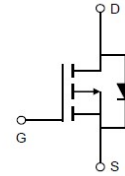
• **Ordering Information:**

Part NO.	ZMA930P06T
Marking	930P06
Packing Information	REEL TAPE
Basic ordering unit (pcs)	3000

• **Absolute Maximum Ratings** ($T_C=25^{\circ}\text{C}$)

Parameter	Symbol	Conditions	Value	Unit
Drain-Source Voltage	V_{DS}		-60	V
Gate-Source Voltage	V_{GS}		± 20	V
Continuous Drain Current	I_D	$T_C=25^{\circ}\text{C}$	-2.0	A
	I_D	$T_C=75^{\circ}\text{C}$	-1.98	A
	I_D	$T_C=100^{\circ}\text{C}$	-1.59	A
Pulsed Drain Current	I_{DM}	Pulsed; $t_p \leq 10 \mu\text{s}$; $T_{mb} = 25^{\circ}\text{C}$;	-8	A
Total Power Dissipation	P_D	$T_C=25^{\circ}\text{C}$	2	W
Total Power Dissipation	P_D	$T_A=25^{\circ}\text{C}$	0.7	W
Operating Junction Temperature	T_J		-55 to +150	$^{\circ}\text{C}$
Storage Temperature	T_{STG}		-55 to +150	$^{\circ}\text{C}$
Single Pulse Avalanche Energy	E_{AS}	$L=0.1\text{mH}$, $V_{GS}=-10\text{V}$, $R_g=25\Omega$,	1.2	mJ
		$L=0.5\text{mH}$, $V_{GS}=-10\text{V}$, $R_g=25\Omega$,	2.52	mJ
ESD Level (HBM)	CLASS 1C			

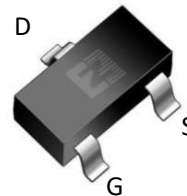
• **Product Summary**



$$V_{DS} = -60\text{V}$$

$$R_{DS(ON)} = 103\text{m}\Omega$$

$$I_D = -2\text{A}$$



SOT-23-3



•Thermal resistance

Parameter	Symbol	Min.	Typ.	Max.	Unit
Thermal resistance, junction - case	R_{thJC}		-	80	°C/W
Thermal resistance, junction-ambient ^①	R_{thJA}		-	180	°C/W
Soldering temperature	T_{sold}		-	260	°C

•Electronic Characteristics

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{GS}=0V, I_D=-250\mu A$	-60			V
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{GS}=V_{DS}, I_D=-250\mu A$	-1.3	-1.8	-2.5	V
Drain-Source Leakage Current	I_{DSS}	$V_{GS}=0V, V_{DS}=-60V$			1.0	μA
Gate- Source Leakage Current	I_{GSS}	$V_{GS}=\pm 20V, V_{DS}=0V$			100	nA
Static Drain-source On Resistance	$R_{DS(ON)}$	$V_{GS}=-10V, I_D=-1.5A$		103	130	m Ω
		$V_{GS}=-4.5V, I_D=-1A$		128	166	m Ω
Forward Transconductance	g_{FS}	$V_{DS}=-5V, I_{SD}=-1A$		20		S
Diode Forward Voltage	V_{FSD}	$V_{GS}=0V, I_{SD}=-1.5A$			1.3	V

•Dynamic characteristics

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit
Input capacitance	C_{iss}	$f = 1MHz, V_{DS}=-25V$	-	650	-	pF
Output capacitance	C_{oss}		-	95	-	
Reverse transfer capacitance	C_{rss}		-	70	-	
Gate Resistance	R_g	$f = 1MHz$	-	8		Ω
Total gate charge	Q_g	$V_{DD} = -15V,$ $I_D = -1A,$ $V_{GS} = -10V$	-	12	-	nC
	$Q_g(-4.5v)$		-	21	-	
Gate - Source charge	Q_{gs}		-	1.6	-	
Gate - Drain charge	Q_{gd}		-	2.6	-	
Turn-ON Delay time	$t_{D(on)}$	$V_{GS}=-10V, V_{DS}=-15V,$ $R_G=3.3\Omega, I_D=-1A$	-	6.5	-	ns
Turn-ON Rise time	t_r		-	8	-	ns
Turn-Off Delay time	$t_{D(off)}$		-	16.5	-	ns
Turn-Off Fall time	t_f		-	4	-	ns

Fig.1 Gate-Charge Characteristics

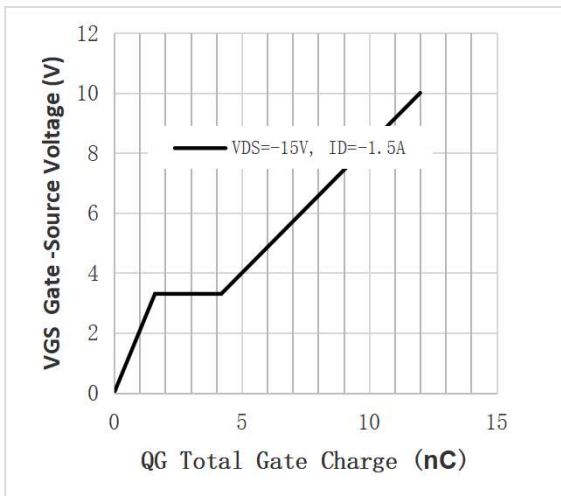


Fig.2 Capacitance Characteristics

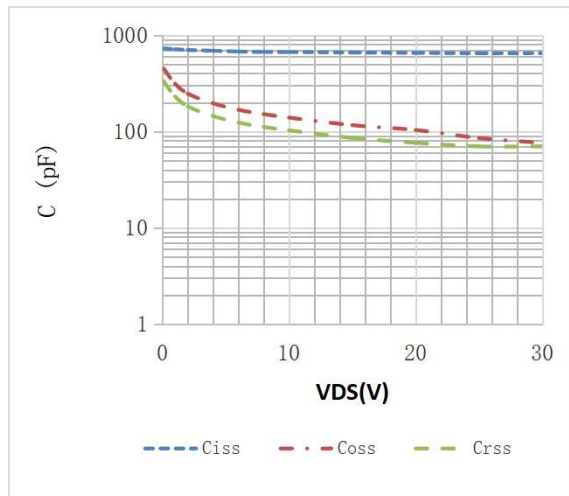


Fig.3 Power Dissipation

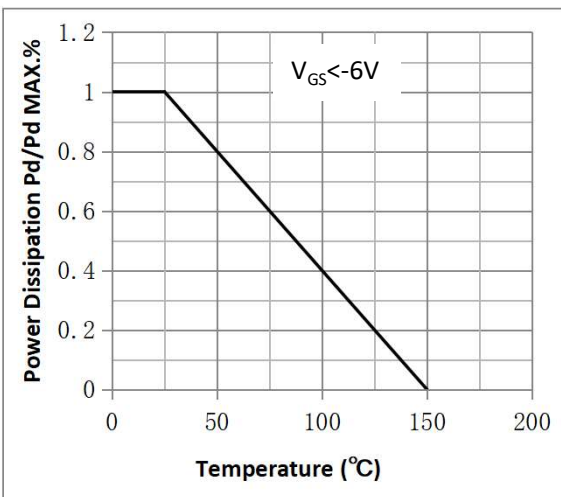


Fig.4 Typical output Characteristics

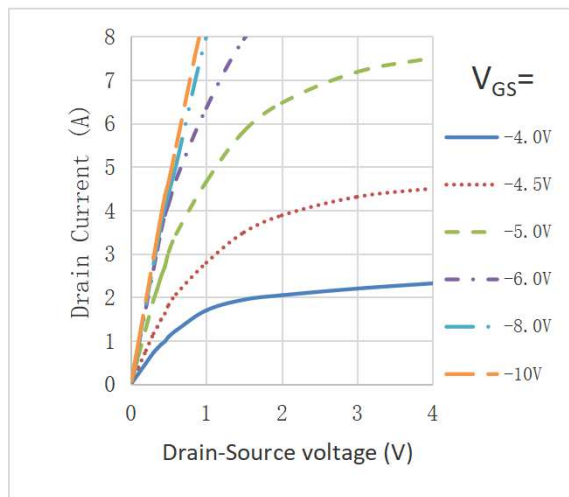


Fig.5 Threshold Voltage V.S Junction Temperature

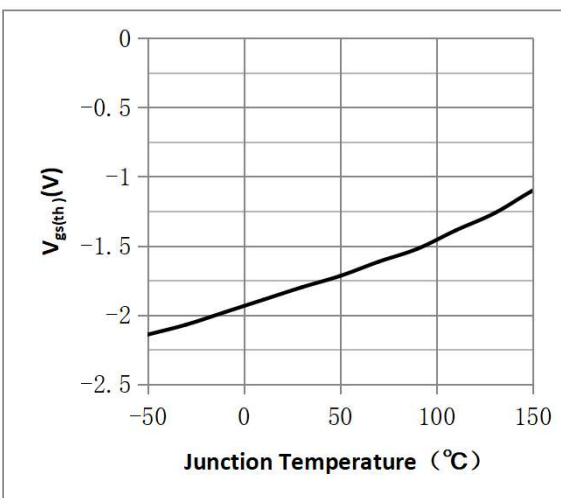


Fig.6 Resistance V.S Drain Current

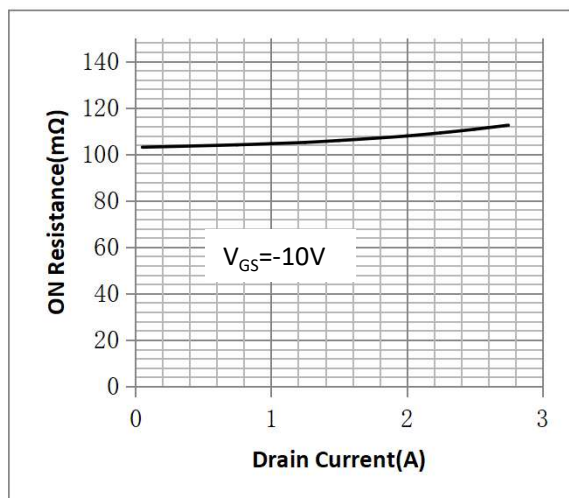


Fig.7 On-Resistance VS Gate Source Voltage

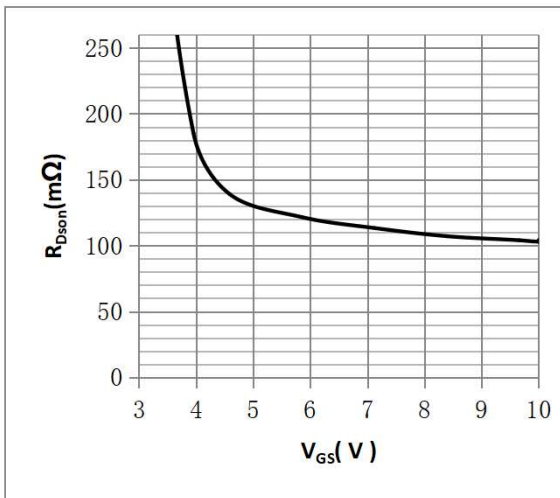


Fig.8 On-Resistance V.S Junction Temperature

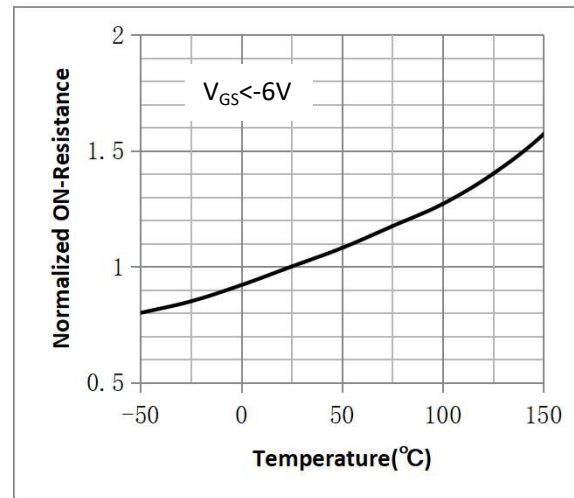


Figure 9. Diode Forward Voltage vs. Current

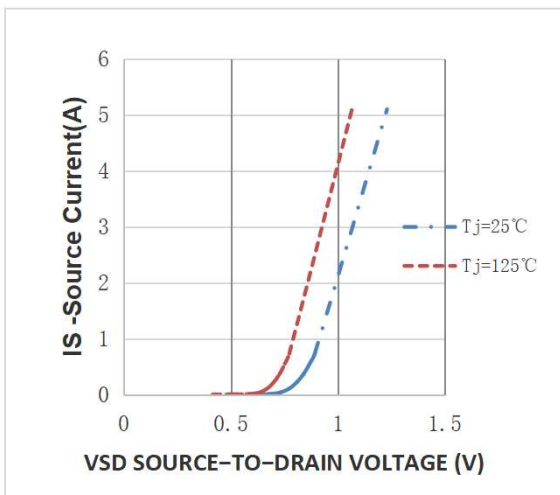


Figure 10. Transfer Characteristics

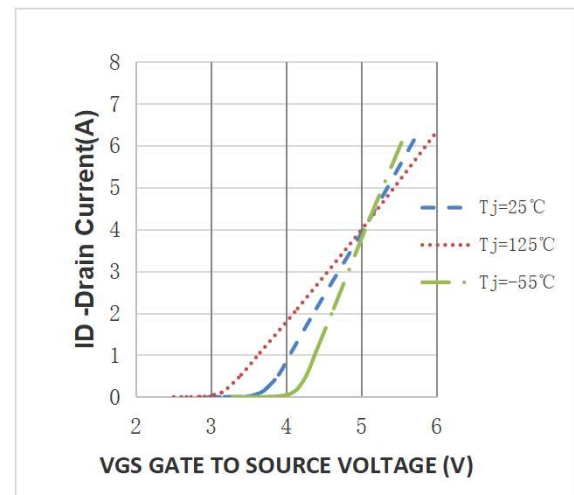


Fig.11 Safe Operating Area

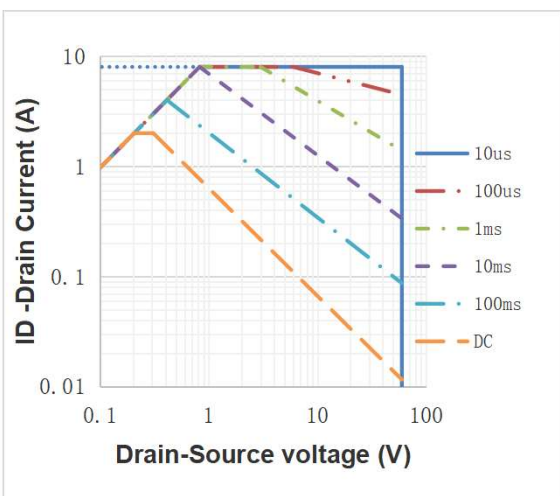
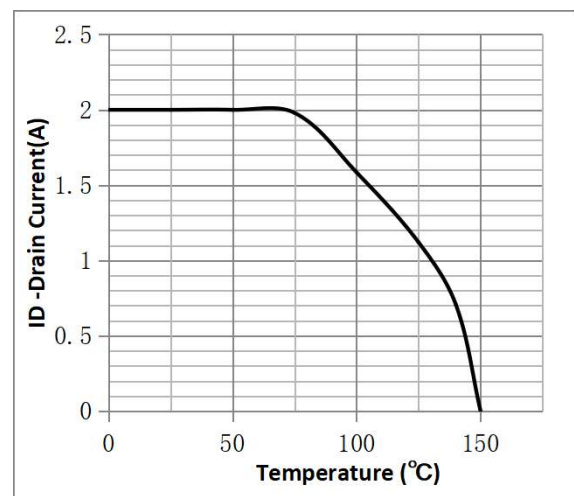
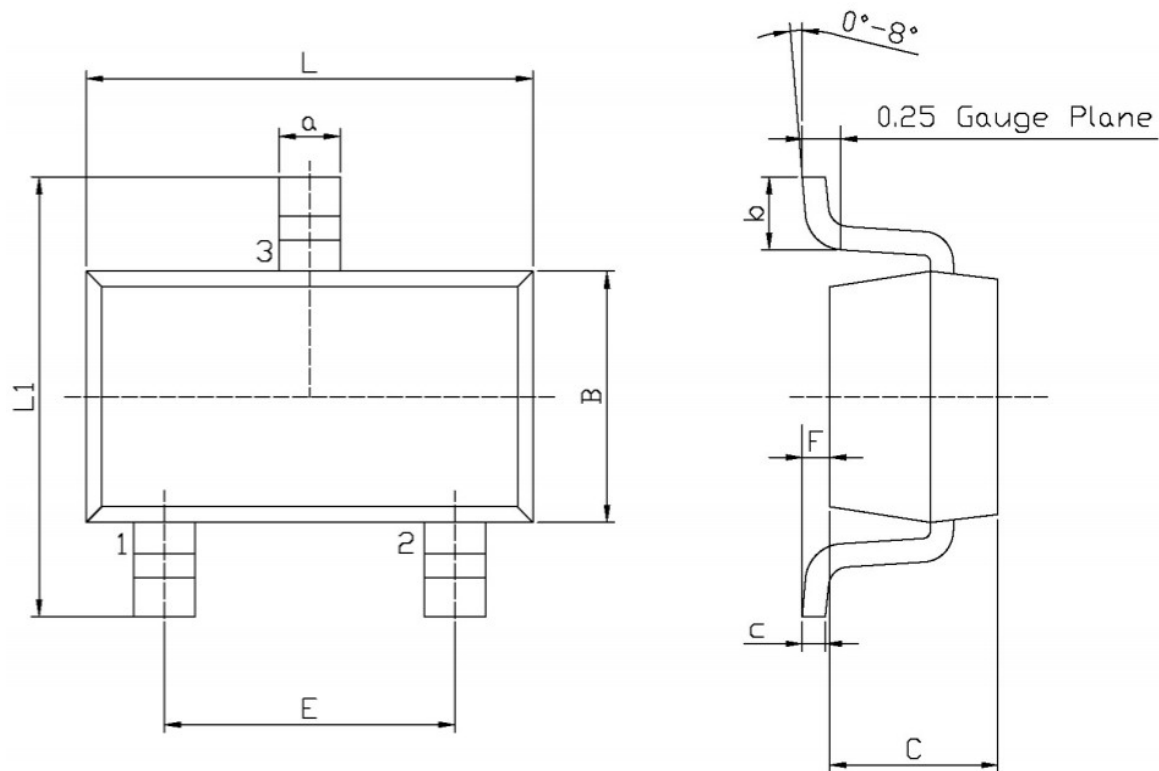


Fig.12 ID vs. Case Temperature^②



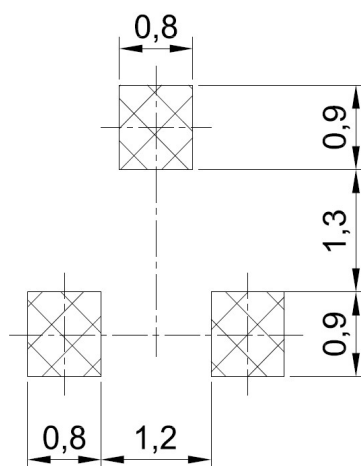
•SOT-23-3 Package Outline



Unit: mm

Symbol	Dimensions In Millimeters		Symbol	Dimensions In Millimeters	
	Min	Max		Min	Max
L	2.82	3.02	a	0.35	0.50
B	1.50	1.70	c	0.10	0.20
C	0.90	1.30	b	0.35	0.55
L1	2.60	3.00	F	0	0.15
E	1.80	2.00			

**Land Pattern
(Only for Reference)**



Note:

- ① Device mounted on FR-4 substrate PC board, 2oz copper, with thermal bias to bottom layer 1inch square copper plate;
- ② Practically the current will be limited by PCB, thermal design and operating temperature. $V_{GS} = -10V$.

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Revision History

Version	Date	Change
A	2022.1.3	NEW
B	2022.5.7	1.Add Reach,HF figure
C	2022.9.9	1.Add Dynamic characteristics
D	2022.10.30	Add SOA/ID Figure
E	2025.5.12	Modify ESD level(HBM).
F	2025.12.15	Add reference land pattern.